Scopus Search Sources Alerts Lists Help SciVal 7 Register Login Author details Receive emails when this author publishes new articles Follow this Author Li, Xin About Scopus Author Identifier | View potential author matches Carnegie Mellon University, Department of Other name formats: Li, X. Get citation alerts Electrical & Computer Engineering, Pittsburgh, United States Author ID: 55983775200 Request author detail corrections Export profile to SciVal Documents: 149 Analyze author output Citations: 1328 total citations by 919 documents View citation overview Documents h-index: 19 View h-graph Co-authors: 150 (maximum 150 co-authors can be displayed) Subject area: Computer Science, Engineering View More 0 149 Documents | Cited by 919 documents | 150 co-authors 2007 Years 149 documents View all in search results format Sort on: Date Cited by ... ■ Documents → Citations **Author History** Add all to list | Set document alert | Export all Set document feed Publication range: 2003 - 2016 Pandey, A., Jereminov, 2016 2016 IEEE Green M., Li, X., Hug, G., Energy and System Aggregated load and generation equivalent circuit models with semi-empirical data fitting 0 References: 1896 Energy and Systems Conference, IGSEC Pileggi, L. Source history: 2016 IEEE Design and Test View docur Proceedings of the International Symposium on Physical View at Publisher Find it 6 NTU Design View docur IEEE Journal of Solid-State Circuits View docur Pandey, A., Jereminov, 2016 2016 IEEE Power and M., Li, X., Hug, G., Energy Society Unified power system analyses and models using 0 Energy Society Innovative Smart Grid Pileggi, L. Show Related Affiliations Technologies Conference, ISGT 2016 Find it 6 NTU View at Publisher Efficient Hybrid Performance Modeling for Analog Circuits Using Hierarchical Shrinkage Priors Liao, C., Tao, J., Yu, H., (...), Zeng, X., Li, X. IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems Find it 6 NTU View at Publisher Yu, H., Tao, J., Liao, C., (...), Zeng, X., Li, X. Efficient statistical analysis for correlated rare failure events via asymptotic probability approximation 2016 IEEE/ACM International 0 Computer-Aided Design, Digest of Technica Papers, ICCAD View at Publisher Find it 6 NTU 2016 IEEE/ACM International Efficient statistical validation of machine learning systems Shi, W., Alawieh, M.B., 0 Li, X., (...), Arechiga, N., Tomatsu, N. Conference on Computer-Aided Design, Digest of Technical Papers, ICCAD Find it 6 NTU View at Publisher Guest Editors' Introduction Challenges and Opportunities Li, X., Kashyap, C., 2016 IEEE Design and Test 0 in Analog/Mixed-Signal CAD View at Publisher Find it 6 NTU Overview of cyber-physical temperature estimation in Proceedings - IEEE INFOCOM Chen, X., Li, X., Tan, 0 smart buildings: From modeling to measurements S.X.-D. Find it 6 NTU View at Publisher Proceedings of IEEE Computer Society Message from the general chairs Li. H.H., Li. X. n Annual Symposium on VLSI, ISVLSI Find it 6 NTU View at Publisher

View at Publisher	results per page			Page	4
	erging Memories - Technology, oplications (First Issue)	Ghosh, S., Joshi, R.V., Somasekhar, D., Li, X.	2016	IEEE Journal on Emerging and Selected Topics in Circuits and Systems	0
	nalog and mixed-signal circuits	Yang, F., (), Zhou, D., Li, X.		Automation Conference	
View at Publisher Efficient performan	Find it S NTU ce modeling via Dual-Prior Bayesian	Huang, Q., Fang, C.,	2016	Proceedings - Design	0
	ce modeling of analog integrated ensity based sparse regression	Fang, C., Huang, Q., Yang, F., (), Zhou, D., Li, X.	2016	Proceedings - Design Automation Conference	0
View at Publisher	Find it 6 NTU	- O	0000		
	n Model Fusion: Efficient performance cale tunable analog/RF integrated	Wang, F., Li, X.	2016	Proceedings - Design Automation Conference	0
View at Publisher	Find it 6 NTU				
View at Publisher An equivalent circu flow analysis of dis	it formulation for three-phase power	Jereminov, M., Bromberg, D.M., Pandey, A., (), Hug, G., Pileggi, L.	2016	Proceedings of the IEEE Power Engineering Society Transmission and Distribution Conference	2
A Grant David	Find it 6 NTU			and Distribution Conference	
View at Publisher Improving robustne flow analysis	Find it S NTU ss and modeling generality for power	Jereminov, M., Bromberg, D.M., Li, X., Hug, G., Pileggi, L.	2016	Power Engineering Society Transmission	1
wafer clustering		F., Li, X.	2010	International Symposium on Circuits and Systems	Ü
View at Publisher	Find it 6 NTU tic spatial failure patterns through	Alawieh, M.B., Wang,	2016	Proceedings - IEEE	0
Virtual temperature Bayesian model fus	measurement for smart buildings via sion	Chen, X., Li, X.	2016	Proceedings - IEEE International Symposium on Circuits and Systems	1
View at Publisher	Find it 6 NTU				
	sion: Large-scale performance and mixed-signal circuits by reusing	Wang, F., Cachecho, P., Zhang, W., (), Kanj, R., Gu, C.	2016	IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems	1
View at Publisher	Find it 6 NTU				
Overview of Circuit Spintronics	s, Systems, and Applications of	Ghosh, S., Iyengar, A., Motaman, S., (), Joshi, R., Somasekhar, D.	2016	IEEE Journal on Emerging and Selected Topics in Circuits and Systems	0
View at Publisher	Find it 6 NTU				
	Telegraph Noise as a Randomness lication in True Random Number	Chen, X., Wang, L., Li, B., (), Liu, Y., Yang, H.	2016	IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems	1
View at Publisher	Find it 6 NTU				
	oplications (Second Issue)			Topics in Circuits and Systems	

The data displayed above is compiled exclusively from articles published in the Scopus database. To request corrections to any inaccuracies or provide any further feedback, please contact us (registration required). The data displayed above is subject to the privacy conditions contained in the privacy policy.

About Scopus

What is Scopus Content coverage Scopus blog

Scopus API
Privacy matters

Language

日本語に切り替える 切換到筒体中文 切換到繁體中文 Русский язык Customer Service

Help Contact us

ELSEVIER

Terms and conditions

Privacy policy

Copyright © 2017 Elsevier B.V. All rights reserved. Scopus® is a registered trademark of Elsevier B.V. Cookies are set by this site. To decline them or learn more, visit our Cookies page.

RELX Grou